Notice of References Cited Application/Control No. 10/084,019 Examiner Venkatesh Haliyur Applicant(s)/Patent Under Reexamination TIEDEMANN ET AL. Art Unit Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2002/0150065	10-2002	Ponnekanti, Seshaiah	370/334
*	В	US-2004/0013103	01-2004	Zhang et al.	370/345
*	O	US-6,947,475	09-2005	Sendonaris et al.	375/148
*	D	US-2003/0171118	09-2003	Miya, Kazuyuki	455/442
*	E	US-6,208,632	03-2001	Kowalski et al.	370/335
*	F	US-2002/0101839	08-2002	Farley et al.	370/329
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
	К	US-			
. .	L.	US-			
:	М	US-			

FOREIGN PATENT DOCUMENTS

TOTALION TATENTO						
*	:	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	υ	
	V	
	w	
	х	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.